



BSI Standards Publication

**Evaluation of thickness, density and interface width
of thin films by X-ray reflectometry — Instrumental
requirements, alignment and positioning, data
collection, data analysis and reporting**

National foreword

This British Standard is the UK implementation of ISO 16413:2020. It supersedes BS ISO 16413:2013, which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee CII/60, Surface chemical analysis.

A list of organizations represented on this committee can be obtained on request to its committee manager.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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